

**TITLE**

by

**Kraig Andrews**

Ph.D. Disseration Prospectus

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Advisor

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**ABSTRACT**

**TITLE HERE**

by

**Kraig J. Andrews**

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Advisor: Dr. Zhixain Zhou  
Major: Physics  
Degree: Doctor of Philosophy

Abstract here

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# Chapter 1

## Introduction

### 1.1 The Conception of Semiconductors

Here we present work by [2, 1].

Semiconductor	Band Gap (eV)	Electron Mobility <sup>1</sup> (cm <sup>2</sup> /V · s)	Hole Mobility <sup>1</sup> (cm <sup>2</sup> /V · s)	Lattice Constant (Å)
Si	1.12	1,500	470	5.43095 <sup>a</sup>
Ge	0.67	3,900	1,900	5.64613 <sup>a</sup>
GaAs	1.42	8,500	400	5.6533 <sup>b</sup>
CdS	2.5	300	50	5.8320 <sup>c</sup>
AlAs	2.16	1,200	400	5.6622 <sup>b</sup>
ZnS	3.66	165	5	5.410 <sup>d</sup>

Table 1.1: Selected properties of some common semiconductors at  $T = 300$  K. Adapted from ref. [5].

<sup>1</sup> Drift mobilities in the purest materials.  
<sup>a</sup> Diamond cubic crystal structure [4].  
<sup>b</sup> Zinc blende crystal structure [3].  
<sup>c</sup> Hexagonal and cubic... citation needed.  
<sup>d</sup> Notes on ZnS structure.

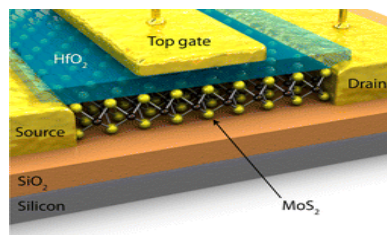


Figure 1.1: Name

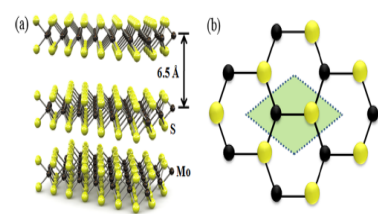


Figure 1.2: name

2D material	theoretical $E_g$ (eV)	experimental $E_g$ (eV)
graphene	0	0
bilayer graphene	0	0
bulk $h$ -BN		5.97
monolayer $h$ -BN		6.07
few layer (2-5) $h$ -BN		5.92
bulk $\text{MoS}_2$	1.2 <sup>a</sup>	1.0-1.29 <sup>a</sup>
monolayer $\text{MoS}_2$	$\sim 1.90$ <sup>b</sup>	$\sim 1.90$ <sup>b</sup>
bulk $\text{WS}_2$	$\sim 1.30$ <sup>a</sup>	$\sim 1.35$ <sup>a</sup>
monolayer $\text{WS}_2$	$\sim 2.10$ <sup>b</sup>	

Table 1.2: Summary of the band gaps of typical monolayer, bilayer, and bulk TMDs and  $h$ -BN materials. Table adapted from ref. [6].

<sup>a</sup> Indirect band gap semiconductor.

<sup>b</sup> Direct band gap semiconductor.

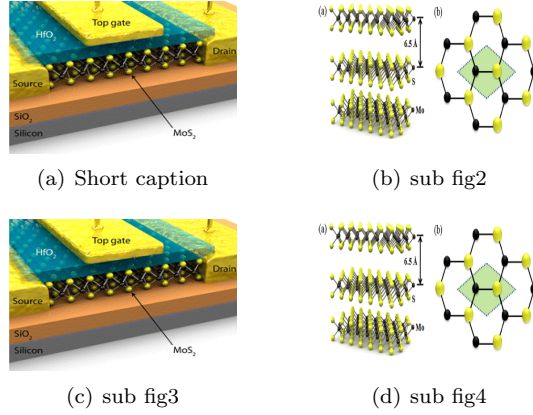


Figure 1.3: main caption

## 1.2 Evolution of Semiconductors

## 1.3 Interest and Development of Two-dimensional Materials

## 1.4 Current State of Two-dimensional Materials



## Chapter 2

# Chapter 2

### 2.1 Section Heading

## Chapter 3

# Chapter 3

### 3.1 Section Heading

## Chapter 4

# Conclusion

### 4.1 Heading

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# Appendices

## Appendix A

### Acronyms